

August 2015

Dual N & P-Channel PowerTrench[®] MOSFET N-Channel: 150 V, 27 A, 30 m Ω P-Channel: -150 V, -2.2 A, 1200 m Ω

Features

Q1: N-Channel

- Max $r_{DS(on)}$ = 30 m Ω at V_{GS} = 10 V, I_D = 6.2 A
- Max $r_{DS(on)}$ = 41 m Ω at V_{GS} = 6 V, I_D = 5.2 A

Q2: P-Channel

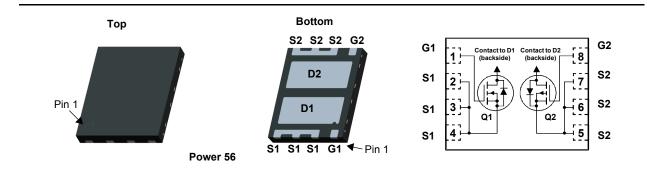
- Max $r_{DS(on)}$ = 1200 m Ω at V_{GS} = -10 V, I_D = -1 A
- Max $r_{DS(on)}$ = 1400 m Ω at V_{GS} = -6 V, I_D = -0.9 A
- Optimised for active clamp forward converters
- RoHS Compliant

General Description

These dual N and P-Channel enhancement mode Power MOSFETs are produced using Fairchild Semiconductor's advanced PowerTrench[®] process that has been especially tailored to minimize on-state resistance and yet maintain superior switching performance. Shrinking the area needed for implementation of active clamp topology; enabling best in class power density.

Applications

- DC-DC Converter
- Active Clamp



MOSFET Maximum Ratings T_A = 25 °C unless otherwise noted

Symbol	Paramete	er		Q1	Q2	Units
V _{DS}	Drain to Source Voltage			150	-150	V
V _{GS}	Gate to Source Voltage			±20	±25	V
I _D	Drain Current -Continuous	T _C = 25 °C		27	-2.2	
	Drain Current -Continuous $T_{C} = 100 \ ^{\circ}C$		(Note 5)	17	-1.4	•
	-Continuous T _A = 25 °C			6.2 ^{1a}	-1 ^{1b}	A
	-Pulsed (Note 4)				-8.8	
E _{AS}	Single Pulse Avalanche Energy		(Note 3)	216	6	mJ
	Power Dissipation for Single Operation	T _A = 25 °C		2.3 ^{1a}	2.3 ^{1b}	
P _D	Power Dissipation for Single Operation $T_A = 25 \text{ °C}$			0.9 ^{1c}	0.9 ^{1d}	W
	Power Dissipation for Single Operation $T_{\rm C} = 25 ^{\circ}{\rm C}$			50	12.5	
T _J , T _{STG}	Operating and Storage Junction Temperature Range			-55 to	+150	°C

Thermal Characteristics

$R_{ ext{ heta}JA}$	Thermal Resistance, Junction to Ambient		55 ^{1b}	
$R_{ ext{ heta}JA}$	Thermal Resistance, Junction to Ambient	138 ^{1c}	138 ^{1d}	°C/W
$R_{ ext{ heta}JC}$	Thermal Resistance, Junction to Case	2.5	10	

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDMS8095AC	FDMS8095AC	Power 56	13"	12 mm	3000 units

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Symbol	Parameter	Test Conditions	Туре	Min	Тур	Max	Units
Off Chara	cteristics						1
BV _{DSS}	Drain to Source Breakdown Voltage	$I_D = 250 \ \mu A, V_{GS} = 0 \ V$ $I_D = -250 \ \mu A, V_{GS} = 0 \ V$	Q1 Q2	150 -150			V
ΔΒV _{DSS} ΔΤ _J	Breakdown Voltage Temperature Coefficient	I_D = 250 µA, referenced to 25 °C I_D = -250 µA, referenced to 25 °C	Q1 Q2		103 122		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 120 V, V_{GS} = 0 V$ $V_{DS} = -120 V, V_{GS} = 0 V$	Q1 Q2			1 -1	μA
I _{GSS}	Gate to Source Leakage Current	$V_{GS} = \pm 20 V, V_{DS} = 0 V$ $V_{GS} = \pm 25 V, V_{DS} = 0 V$	Q1 Q2			±100 ±100	nA nA
On Chara	cteristics	+ · · · ·					
V _{GS(th)}	Gate to Source Threshold Voltage	V _{GS} = V _{DS} , I _D = 250 μA V _{GS} = V _{DS} , I _D = -250 μA	Q1 Q2	2.0 -2.0	3.2 -3.2	4.0 -4.0	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	I_D = 250 µA, referenced to 25 °C I_D = -250 µA, referenced to 25 °C	Q1 Q2		-11 -6		mV/°C
r _{DS(on)}	Static Drain to Source On Resistance	$V_{GS} = 10 \text{ V}, I_D = 6.2 \text{ A}$ $V_{GS} = 6 \text{ V}, I_D = 5.2 \text{ A}$ $V_{GS} = 10 \text{ V}, I_D = 6.2 \text{ A}, T_J = 125 ^{\circ}\text{C}$	Q1		25 33 48	30 41 58	- mΩ
		$V_{GS} = -10 V, I_D = -1 A$ $V_{GS} = -6 V, I_D = -0.9 A$ $V_{GS} = -10 V, I_D = -1 A, T_J = 125 °C$	Q2		840 940 1520	1200 1400 2171	
9 _{FS}	Forward Transconductance	$V_{DD} = 10 V, I_D = 6.2 A$ $V_{DD} = -10 V, I_D = -1 A$	Q1 Q2		19 0.75		S
Dynamic	Characteristics						
C _{iss}	Input Capacitance	Q1 V _{DS} = 75 V, V _{GS} = 0 V, f = 1 MHZ	Q1 Q2		1441 162	2020 230	pF
C _{oss}	Output Capacitance	Q2	Q1 Q2		127 13	180 25	pF
C _{rss}	Reverse Transfer Capacitance	V _{DS} = -75 V, V _{GS} = 0 V, f = 1 MHZ	Q1 Q2		4.4 0.6	10 5	pF
R _g	Gate Resistance		Q1 Q2	0.1 0.1	1.3 3.3	3.3 8.3	Ω
Switching	y Characteristics						
t _{d(on)}	Turn-On Delay Time	Q1	Q1 Q2		12 5.2	22 11	ns
t _r	Rise Time	V_{DD} = 75 V, I _D = 6.2 A, V _{GS} = 10 V, R _{GEN} = 6 Ω	Q1 Q2		2.7 1.6	10 10	ns
t _{d(off)}	Turn-Off Delay Time		Q1 Q2		18 7.4	33 15	ns
t _f	Fall Time	$V_{GS} = -10$ V, $R_{GEN} = 6 \Omega$	Q1 Q2		4 6.3	10 13	ns
Q _{g(TOT)}	Total Gate Charge	$V_{GS} = 0 V \text{ to } 10 V$ $V_{GS} = 0 V \text{ to } -10 V$ $V_{DQ} = 75 V$	Q1 Q2		21 2.8	30 4	nC
Q _{g(TOT)}	Total Gate Charge	$\begin{array}{c} V_{GS} = 0 \ V \ to \ -10 \ V \\ V_{GS} = 0 \ V \ to \ 6 \ V \\ V_{GS} = 0 \ V \ to \ 6 \ V \\ I_D = 6.2 \ A \end{array}$	Q1 Q2		13 1.8	19 2.6	nC
Q _{gs}	Gate to Source Charge	Q2	Q1 Q2		6.7 0.8		nC
Q _{gd}	Gate to Drain "Miller" Charge	- V _{DD} = -75 V I _D = -1 A	Q1 Q2		3.9 0.7		nC

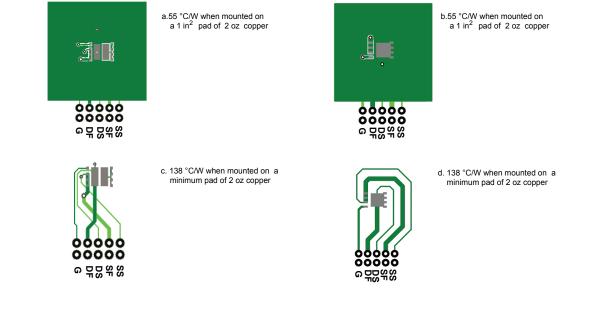
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FDMS8095AC Dual N & P-Cha
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[®] MOSFET

Symbol	Parameter	Test Conditions		Туре	Min	Тур	Max	Units
Drain-Sou	urce Diode Characteristics							
V _{SD}	Source-Drain Diode Forward Voltage	$V_{GS} = 0 V, I_S = 6.2 A$ $V_{GS} = 0 V, I_S = -1 A$	(Note 2) (Note 2)	Q1 Q2		0.8 -0.9	1.3 -1.3	V
t _{rr}	Reverse Recovery Time	Q1 I _F = 6.2 A, di/dt = 100 A/s		Q1 Q2		69 44	111 71	ns
Q _{rr}	Reverse Recovery Charge	Q2 I _F = -1 A, di/dt = 100 A/s		Q1 Q2		106 68	170 109	nC

Notes:

1. R_{0JA} is determined with the device mounted on a 1in² pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. R_{0CA} is determined by the user's board design.

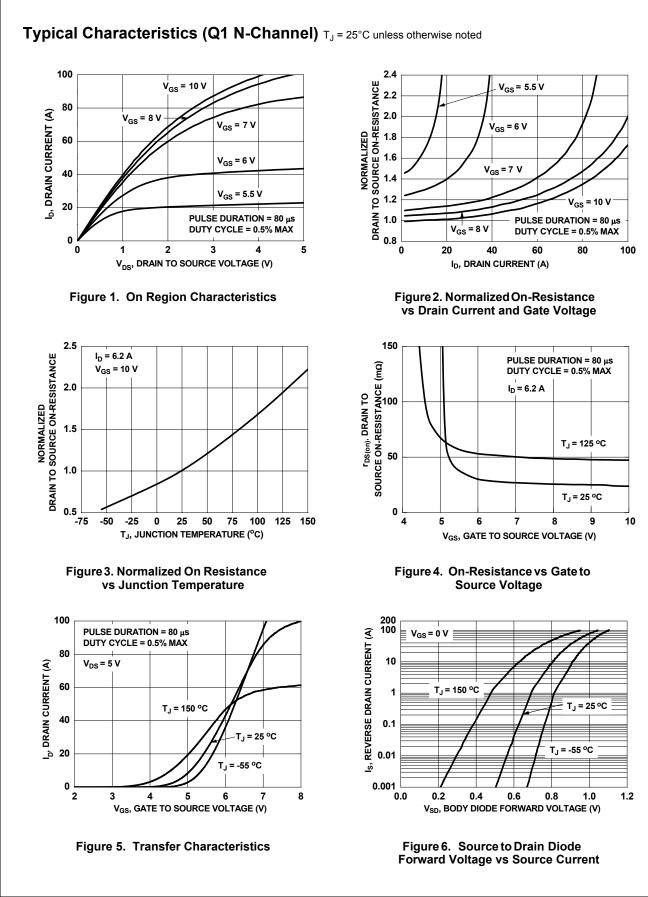


2. Pulse Test: Pulse Width < 300 $\ \mu\text{s},$ Duty cycle < 2.0%.

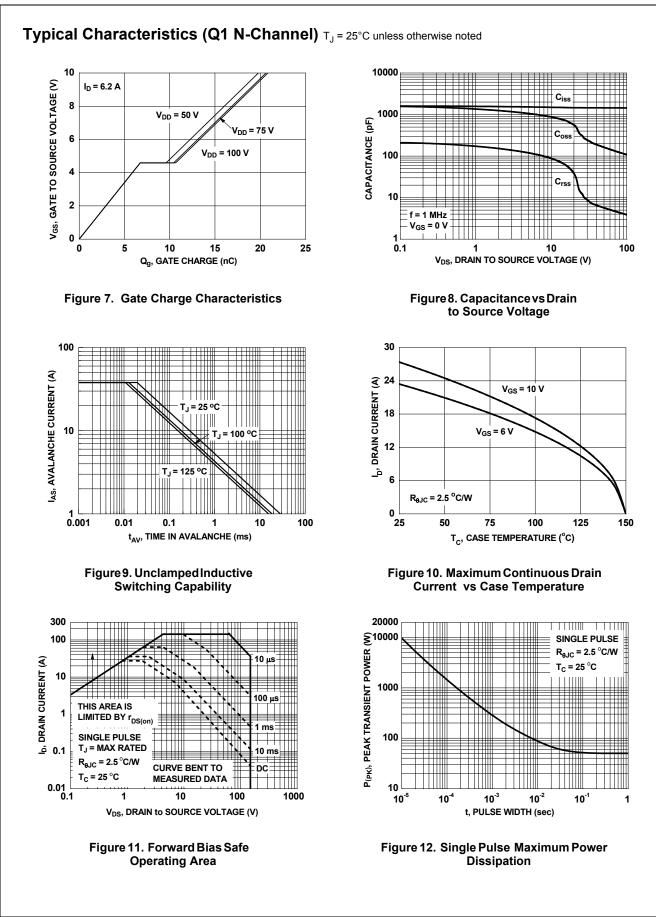
3. Q1: E_{AS} of 216 mJ is based on starting T_J = 25 °C, L = 3 mH, I_{AS} = 12 A, V_{DD} = 150 V, V_{GS} = 10 V. 100% test at L = 0.3 mH, I_{AS} = 28 A. Q2: E_{AS} of 6 mJ is based on starting T_J = 25 °C, L = 3 mH, I_{AS} = -2 A, V_{DD} = -150 V, V_{GS} = -10 V. 100% test at L = 0.3 mH, I_{AS} = -6.9 A.

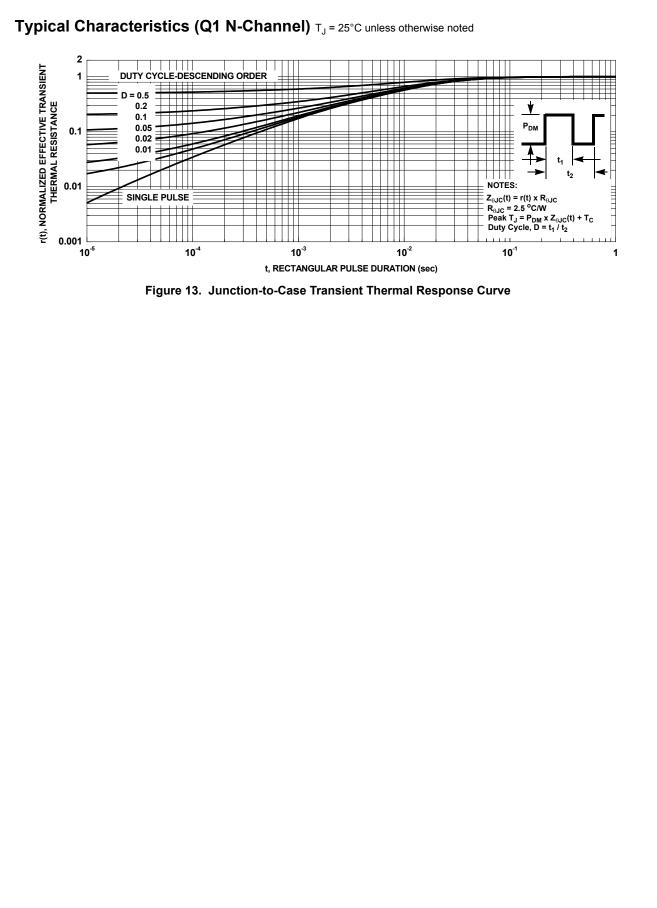
4. Pulsed Id please refer to Fig 11 SOA graph for more details.

5. Computed continuous current limited to Max Junction Temperature only, actual continuous current will be limited by thermal & electro-mechanical application board design.

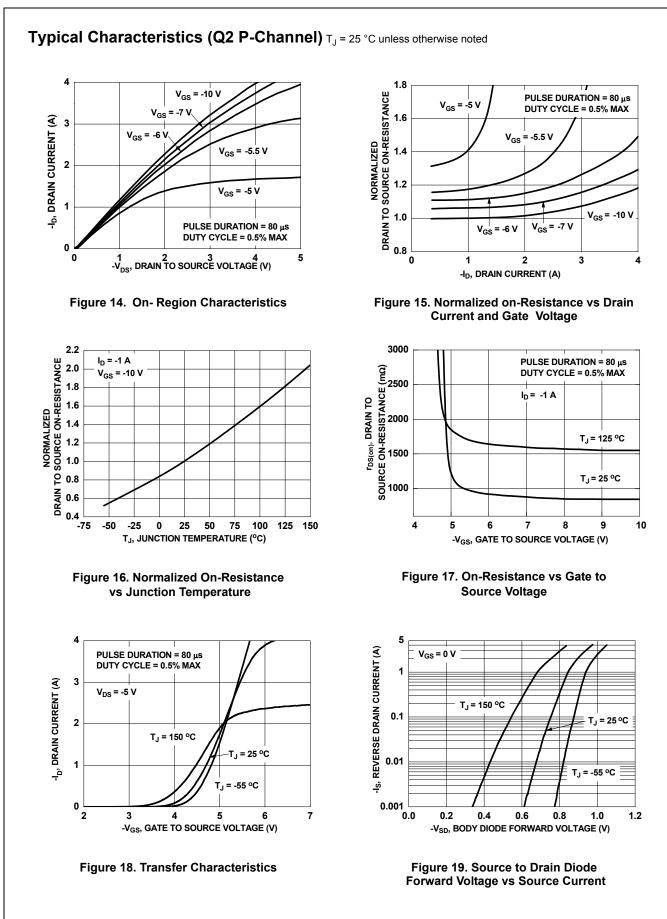


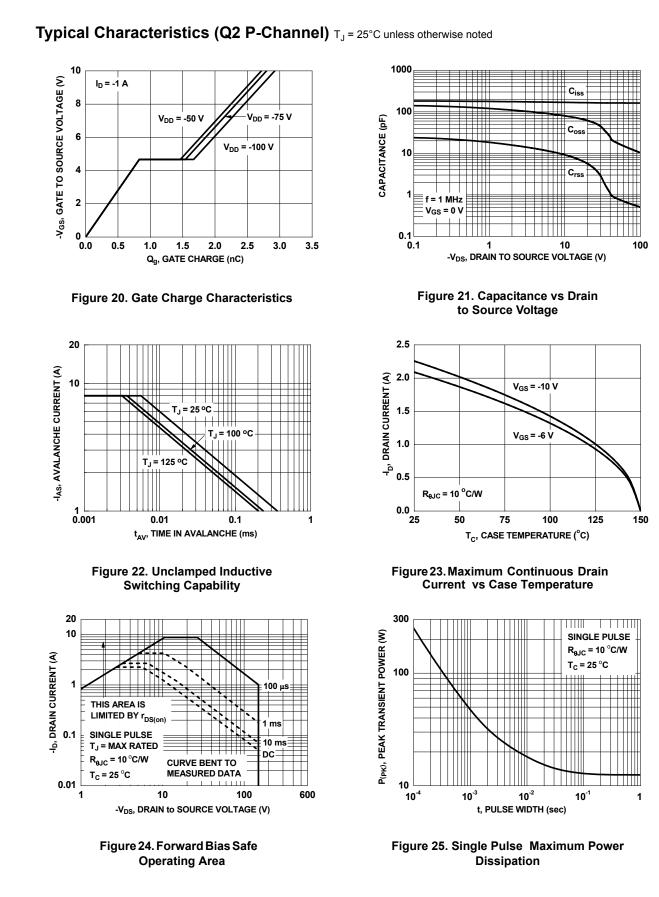






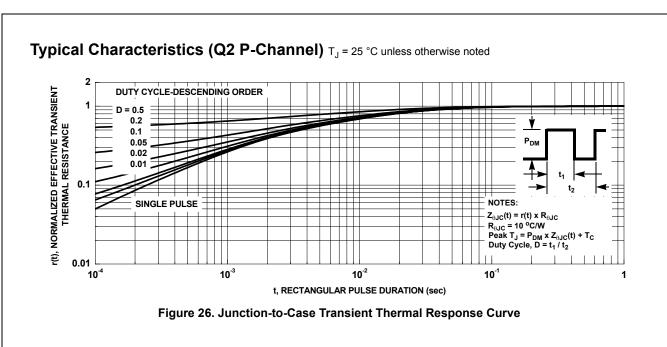
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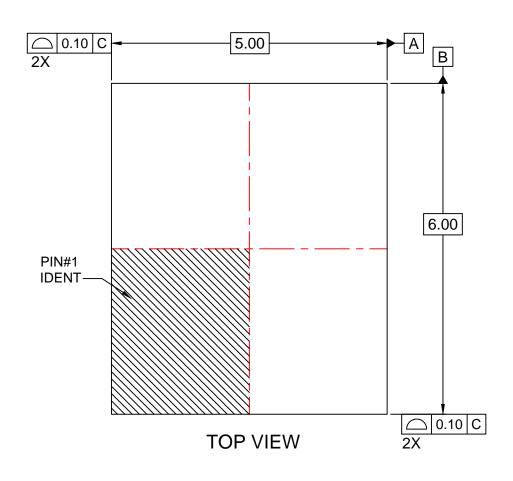


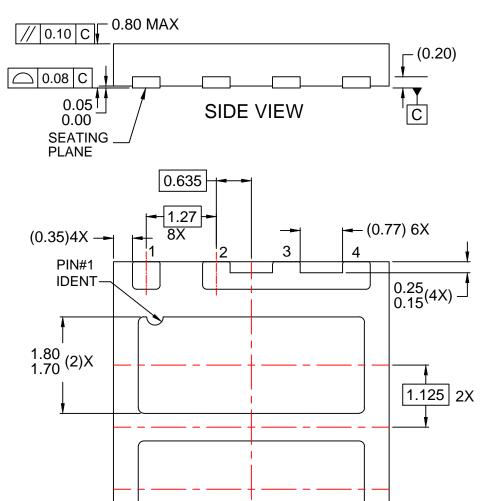


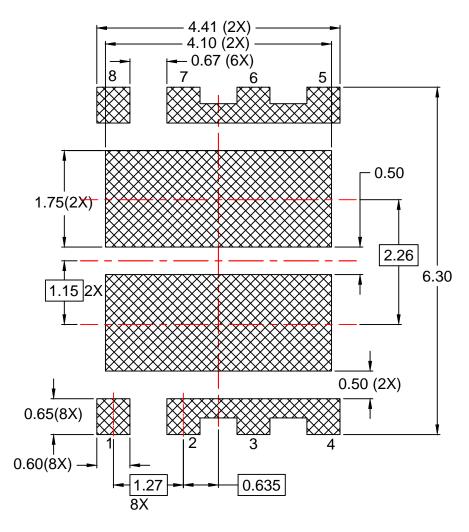
FDMS8095AC Dual N & P-Channel PowerTrench[®] MOSFET







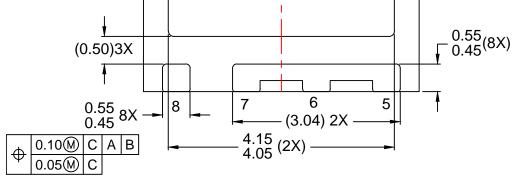




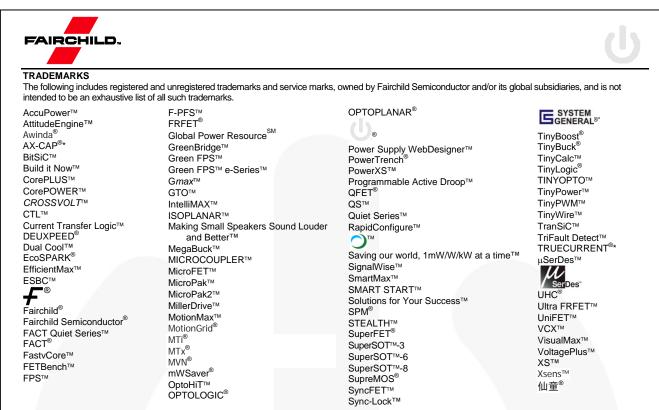
RECOMMENDED LAND PATTERN

NOTES:

- A. DOES NOT FULLY CONFORM TO JEDEC REGISTRATION, MO-229.
- B. DIMENSIONS ARE IN MILLIMETERS.
- C. DIMENSIONS AND TOLERANCES PER ASME Y14.5M, 2009.
- D. LAND PATTERN RECOMMENDATION IS BASED ON FSC DESIGN ONLY.
- E. DRAWING FILENAME: MKT-MLP08Zrev1.



BOTTOM VIEW



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